

Notice of References CitedApplication/Control No.
09/643,321Applicant(s)/Patent Under
Reexamination
CHEN ET AL.Examiner
Yemane M GerezgiherArt Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,628,314	09-2003	Hoyle, Martin David	345/854
	B	US-6,341,304	01-2002	Engbersen et al.	709/203
	C	US-6,337,858	01-2002	Petty et al.	370/356
	D	US-6,374,237	04-2002	Reese, Kenneth W.	707/3
	E	US-6,249,576	06-2001	Sassin et al.	379/218.01
	F	US-6,256,620	07-2001	Jawahar et al.	707/2
	G	US-6,321,256	11-2001	Himmel et al.	709/218
	H	US-5,923,736	07-1999	Shachar, Yuval	379/93.17
	I	US-5,974,398	10-1999	Hanson et al.	705/14
	J	US-6,009,398	12-1999	Mueller et al.	704/275
	K	US-5,996,006	11-1999	Speicher, Gregory J.	709/218
	L	US-4,722,078	01-1988	Nakanishi et al.	369/30.92
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1047251 A2	10-2000	European Patent	ALI et al.	H04M 01/65
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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